Product data sheet

1. General description

The 74LV164-Q100 is an 8-bit edge-triggered shift register with serial data entry and an output from each of the eight stages. Data is entered serially through one of two inputs (DSA or DSB) and either input can be used as an active HIGH enable for data entry through the other input. Both inputs must be connected together or an unused input must be tied HIGH.

Data shifts one place to the right on each LOW-to-HIGH transition of the clock input (CP) and enters into Q0, which is the logical AND-function of the two data inputs (DSA and DSB) that existed one set-up time prior to the rising clock edge.

A LOW on the master reset input (MR) overrides all other inputs and clears the register asynchronously, forcing all outputs LOW.

This product has been qualified to the Automotive Electronics Council (AEC) standard Q100 (Grade 1) and is suitable for use in automotive applications.

2. Features and benefits

- Automotive product qualification in accordance with AEC-Q100 (Grade 1)
 - Specified from -40 °C to +85 °C and from -40 °C to +125 °C
- Wide operating voltage: 1.0 V to 5.5 V
- Optimized for low-voltage applications: 1.0 V to 3.6 V
- Accepts TTL input levels between V_{CC} = 2.7 V and V_{CC} = 3.6 V
- Typical V_{OLP} (output ground bounce): < 0.8 V at V_{CC} = 3.3 V and T_{amb} = 25 °C
- Typical V_{OHV} (output V_{OH} undershoot): > 2 V at V_{CC} = 3.3 V and T_{amb} = 25 °C
- Gated serial data inputs
- · Asynchronous master reset
- · ESD protection:
 - HBM: ANSI/ESDA/JEDEC JS-001 class 2 exceeds 2000 V
 - CDM: ANSI/ESDA/JEDEC JS-002 class C3 exceeds 1000 V
- DHVQFN package with Side-Wettable Flanks enabling Automatic Optical Inspection (AOI) of solder joints

3. Ordering information

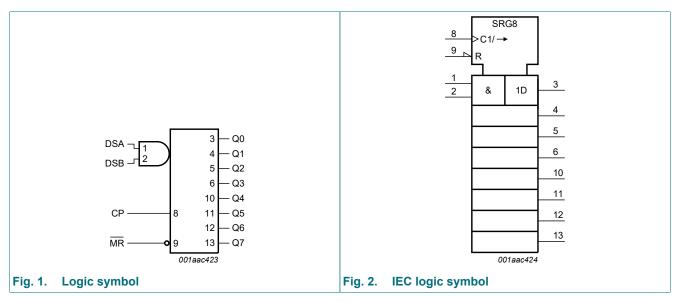
Table 1. Ordering information

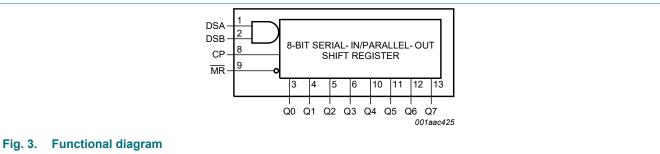
Type number	Package								
	Temperature range	Name	Description	Version					
74LV164D-Q100	-40 °C to +125 °C	SO14	plastic small outline package; 14 leads; body width 3.9 mm	SOT108-1					
74LV164PW-Q100	-40 °C to +125 °C	TSSOP14	plastic thin shrink small outline package; 14 leads; body width 4.4 mm	SOT402-1					
74LV164BQ-Q100	-40 °C to +125 °C	DHVQFN14	plastic dual in-line compatible thermal enhanced very thin quad flat package; no leads; 14 terminals; body 2.5 × 3 × 0.85 mm	SOT762-1					



8-bit serial-in/parallel-out shift register

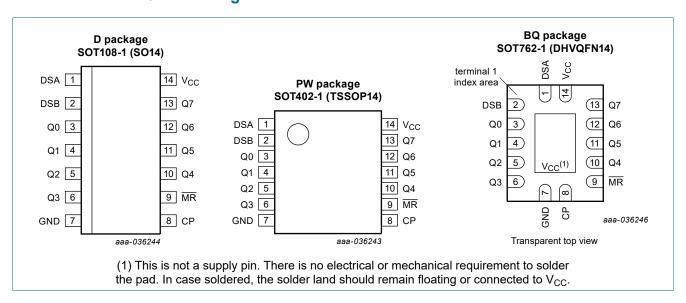
4. Functional diagram





5. Pinning information

5.1. Pinning



8-bit serial-in/parallel-out shift register

5.2. Pin description

Table 2. Pin description

Symbol	Pin	Description		
DSA	1	data input SA		
DSB	2	data input SB		
Q0	3	output 0		
Q1	4	output 1		
Q2	5	output 2		
Q3	6	output 3		
GND	7	ground (0 V)		
СР	8	clock input (edge triggered LOW-to-HIGH)		
MR	9	master reset input (active LOW)		
Q4	10	output 4		
Q5	11	output 5		
Q6	12	output 6		
Q7	13	output 7		
V _{CC}	14	supply voltage		

6. Functional description

Table 3. Function table

 $H = HIGH \ voltage \ level; \ h = HIGH \ voltage \ level \ one \ set-up \ time \ prior \ to \ the \ LOW-to-HIGH \ CP \ transition;$

 $L = LOW \ voltage \ level; \ l = LOW \ voltage \ level \ one \ set-up \ time \ prior \ to \ the \ LOW-to-HIGH \ CP \ transition;$

q = lower case letter indicates the state of referenced input one set-up time prior to the LOW-to-HIGH CP transition;

 \uparrow = LOW-to-HIGH clock transition.

Operating mode	Input		Output			
	MR	СР	DSA	DSB	Q0	Q1 to Q7
Reset (clear)	L	Х	X	Х	L	L to L
Shift	Н	1	I	I	L	q0 to q6
	Н	1	I	h	L	q0 to q6
	Н	1	h	I	L	q0 to q6
	Н	1	h	h	Н	q0 to q6

8-bit serial-in/parallel-out shift register

7. Limiting values

Table 4. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{CC}	supply voltage		-0.5	+7.0	V
I _{IK}	input clamping current	$V_1 < -0.5 \text{ V or } V_1 > V_{CC} + 0.5 \text{ V}$ [1]	-	±20	mA
I _{OK}	output clamping current	$V_O < -0.5 \text{ V or } V_O > V_{CC} + 0.5 \text{ V}$ [1]	-	±50	mA
Io	output current	$V_{O} = -0.5 \text{ V to } (V_{CC} + 0.5 \text{ V})$	-	±25	mA
I _{CC}	supply current		-	50	mA
I _{GND}	ground current		-50	-	mA
T _{stg}	storage temperature		-65	+150	°C
P _{tot}	total power dissipation	$T_{amb} = -40 ^{\circ}\text{C} \text{ to } +125 ^{\circ}\text{C}$ [2]	-	500	mW

^[1] The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

8. Recommended operating conditions

Table 5. Recommended operating conditions

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
V _{CC}	supply voltage	[1]	1.0	3.3	5.5	V
VI	input voltage		0	-	V _{CC}	V
Vo	output voltage		0	-	V _{CC}	V
T _{amb}	ambient temperature		-40	+25	+125	°C
Δt/ΔV	input transition rise and fall rate	V _{CC} = 1.0 V to 2.0 V	-	-	500	ns/V
		V _{CC} = 2.0 V to 2.7 V	-	-	200	ns/V
		V _{CC} = 2.7 V to 3.6 V	-	-	100	ns/V
		V _{CC} = 3.6 V to 5.5 V	-	-	50	ns/V

^[1] The static characteristics are guaranteed from V_{CC} = 1.2 V to V_{CC} = 5.5 V, but LV devices are guaranteed to function down to V_{CC} = 1.0 V (with input levels GND or V_{CC}).

^[2] For SOT108-1 (SO14) package: Ptot derates linearly with 10.1 mW/K above 100 °C.

For SOT402-1 (TSSOP14) package: Ptot derates linearly with 7.3 mW/K above 81 °C.

For SOT762-1 (DHVQFN14) package: Ptot derates linearly with 9.6 mW/K above 98 °C.

8-bit serial-in/parallel-out shift register

9. Static characteristics

Table 6. Static characteristics

Voltages are referenced to GND (ground = 0 V).

Symbol	Parameter	Conditions	-40	°C to +8	85 °C	-40 °C to	Unit	
			Min	Typ[1]	Max	Min	Max	1
V _{IH}	HIGH-level input voltage	V _{CC} = 1.2 V	0.9	-	-	0.9	-	V
		V _{CC} = 2.0 V	1.4	-	-	1.4	-	V
		V _{CC} = 2.7 V to 3.6 V	2.0	-	-	2.0	-	V
		V _{CC} = 4.5 V to 5.5 V	0.7V _{CC}	-	-	0.7V _{CC}	-	V
V _{IL}	LOW-level input voltage	V _{CC} = 1.2 V	-	-	0.3	-	0.3	V
		V _{CC} = 2.0 V	-	-	0.6	-	0.6	V
		V _{CC} = 2.7 V to 3.6 V	-	-	0.8	-	0.8	V
		V _{CC} = 4.5 V to 5.5 V	-	-	0.3V _{CC}	-	0.3V _{CC}	V
V _{OH}	HIGH-level output voltage	$V_I = V_{IH}$ or V_{IL}						
		$I_O = -100 \mu A; V_{CC} = 1.2 V$	-	1.2	-	-	-	V
		$I_O = -100 \mu A; V_{CC} = 2.0 V$	1.8	2.0	-	1.8	-	V
		$I_O = -100 \mu A; V_{CC} = 2.7 V$	2.5	2.7	-	2.5	-	V
		$I_O = -100 \mu A; V_{CC} = 3.0 V$	2.8	3.0	-	2.8	-	V
		$I_O = -100 \mu A; V_{CC} = 4.5 V$	4.3	4.5	-	4.3	-	V
		$I_O = -6 \text{ mA}; V_{CC} = 3.0 \text{ V}$	2.4	2.82	-	2.2	-	V
		$I_O = -12 \text{ mA}; V_{CC} = 4.5 \text{ V}$	3.6	4.2	-	3.5	-	V
V_{OL}	LOW-level output voltage	$V_I = V_{IH}$ or V_{IL}						
		$I_O = 100 \mu A; V_{CC} = 1.2 V$	-	0	-	-	-	V
		$I_O = 100 \mu A; V_{CC} = 2.0 V$	-	0	0.2	-	0.2	V
		$I_O = 100 \mu A; V_{CC} = 2.7 V$	-	0	0.2	-	0.2	V
		$I_O = 100 \mu A; V_{CC} = 3.0 V$	-	0	0.2	-	0.2	V
		$I_O = 100 \mu A; V_{CC} = 4.5 V$	-	0	0.2	-	0.2	V
		I_{O} = 6 mA; V_{CC} = 3.0 V	-	0.25	0.40	-	0.50	V
		$I_O = 12 \text{ mA}; V_{CC} = 4.5 \text{ V}$	-	0.35	0.55	-	0.65	V
l _l	input leakage current	$V_I = V_{CC}$ or GND; $V_{CC} = 5.5 \text{ V}$	-	-	1.0	-	1.0	μΑ
I _{CC}	supply current	$V_I = V_{CC}$ or GND; $I_O = 0$ A; $V_{CC} = 5.5 \text{ V}$	-	-	20.0	-	160	μA
ΔI _{CC}	additional supply current	per input; V _I = V _{CC} - 0.6 V; V _{CC} = 2.7 V to 3.6 V	-	-	500	-	850	μΑ
Cı	input capacitance		-	3.5	-	-	-	pF

^[1] Typical values are measured at T_{amb} = 25 °C.

8-bit serial-in/parallel-out shift register

10. Dynamic characteristics

Table 7. Dynamic characteristics

GND = 0 V; For test circuit see Fig. 7.

Symbol	Parameter	Conditions		-40	°C to +85	°C	-40 °C to +125 °C		Unit
				Min	Typ[1]	Max	Min	Max	
t _{pd}	propagation delay	CP to Qn; see Fig. 4	[2]						
		V _{CC} = 1.2 V		-	75	-	-	-	ns
		V _{CC} = 2.0 V		-	26	39	-	49	ns
		V _{CC} = 2.7 V		-	19	29	-	36	ns
		V _{CC} = 3.3 V; C _L = 15 pF		-	12	-	-	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	-	14	23	-	29	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	-	12	19	-	24	ns
t _{PHL}	HIGH to LOW	MR to Qn; see Fig. 5							
	propagation delay	V _{CC} = 1.2 V		-	75	-	-	-	ns
		V _{CC} = 2.0 V		-	26	39	-	49	ns
		V _{CC} = 2.7 V		-	19	29	-	36	ns
		V _{CC} = 3.3 V; C _L = 15 pF		-	12	-	-	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	-	14	23	-	29	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	-	12	19	-	24	ns
t _W	pulse width	CP; see Fig. 4							
		V _{CC} = 2.0 V		34	9	-	41	-	ns
		V _{CC} = 2.7 V		25	6	-	30	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	20	5	-	24	-	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	13	4	-	16	-	ns
		MR; <u>Fig. 5</u>							
		V _{CC} = 2.0 V		34	10	-	41	-	ns
		V _{CC} = 2.7 V		25	8	-	30	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	20	6	-	24	-	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	13	5	-	16	-	ns
t _{rec}	recovery time	MR to CP; see Fig. 5							
		V _{CC} = 1.2 V		-	30	-	-	-	ns
		V _{CC} = 2.0 V		19	10	-	24	-	ns
		V _{CC} = 2.7 V		14	8	-	18	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	11	6	-	14	-	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	8	5	-	10	-	ns
t _{su}	set-up time	Dn to CP; see Fig. 6							
		V _{CC} = 1.2 V		-	15	-	-	-	ns
		V _{CC} = 2.0 V		22	5	-	26	-	ns
		V _{CC} = 2.7 V		16	4	-	19	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	13	3	-	15	-	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	9	2	-	10	-	ns

8-bit serial-in/parallel-out shift register

Symbol	Parameter	Conditions		-40	°C to +85	°C	-40 °C to +125 °C		Unit
				Min	Typ[1]	Max	Min	Max	
t _h	hold time	Dn to CP; see Fig. 6							
		V _{CC} = 1.2 V		-	-10	-	-	-	ns
		V _{CC} = 2.0 V		5	-3	-	5	-	ns
		V _{CC} = 2.7 V		5	-2	-	5	-	ns
		V _{CC} = 3.0 V to 3.6 V	[3]	5	-2	-	5	-	ns
		V _{CC} = 4.5 V to 5.5 V	[3]	5	-1	-	5	-	ns
f _{max}	maximum	see Fig. 4							
	frequency	V _{CC} = 2.0 V		14	40	-	12	-	MHz
		V _{CC} = 2.7 V		19	58	-	16	-	MHz
		V _{CC} = 3.3 V; C _L = 15 pF		-	78	-	-	-	MHz
		V _{CC} = 3.0 V to 3.6 V	[3]	24	70	-	20	-	MHz
		V _{CC} = 4.5 V to 5.5 V	[3]	36	100	-	30	-	MHz
C _{PD}	power dissipation capacitance	V_{CC} = 3.3 V; C_L = 50 pF; f_i = 1 MHz; V_I = GND to V_{CC}	[4]	-	40	-	-	-	pF

- [1] All typical values are measured at T_{amb} = 25 °C.
- [2] t_{pd} is the same as t_{PLH} and t_{PHL} .
- [3] Typical values are measured at nominal supply voltage (V_{CC} = 3.3 V and V_{CC} = 5.0 V).
- [4] C_{PD} is used to determine the dynamic power dissipation (P_D in μW).

$$P_D = C_{PD} \times V_{CC}^2 \times f_i \times N + \Sigma (C_L \times V_{CC}^2 \times f_o)$$
 where:

f_i = input frequency in MHz, f_o = output frequency in MHz

C_L = output load capacitance in pF

V_{CC} = supply voltage in V

N = number of inputs switching

 $\Sigma(C_L \times V_{CC}^2 \times f_o)$ = sum of the outputs.

10.1. Waveforms and test circuit

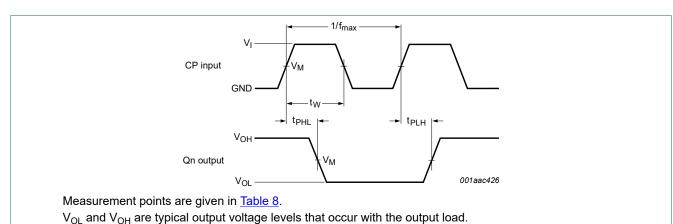
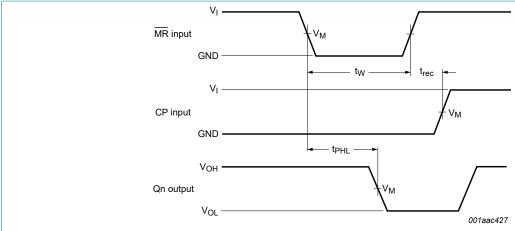


Fig. 4. Propagation delay clock (CP) to output (Qn), clock pulse width and maximum clock frequency

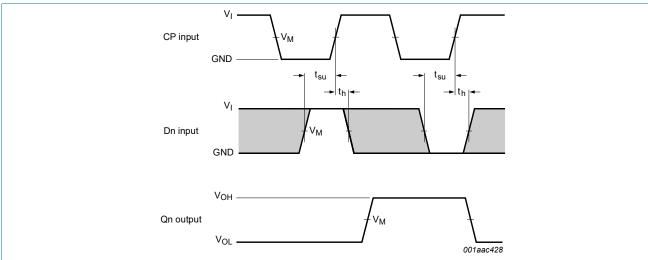
8-bit serial-in/parallel-out shift register



Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

Fig. 5. Pulse width master reset (MR), propagation delay master reset (MR) to output (Qn) and the master reset (MR) to clock (CP) recovery time



Measurement points are given in Table 8.

V_{OL} and V_{OH} are typical output voltage levels that occur with the output load.

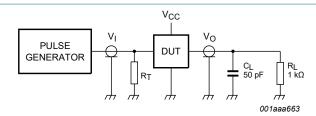
The shaded areas indicate when the input is permitted to change for predictable output performance.

Fig. 6. Data set-up and hold times inputs (Dn) to clock (CP)

Table 8. Measurement points

Supply voltage	Input	Output
V _{CC}	V _M	V _M
1.2 V	0.5 × V _{CC}	0.5 × V _{CC}
2.0 V	0.5 × V _{CC}	0.5 × V _{CC}
2.7 V	1.5 V	1.5 V
3.0 V to 3.6 V	1.5 V	1.5 V
4.5 V to 5.5 V	0.5 × V _{CC}	0.5 × V _{CC}

8-bit serial-in/parallel-out shift register



Test data is given in Table 9.

Definitions for test circuit:

R_L = Load resistance;

C_L = Load capacitance including jig and probe capacitance;

 R_{T} = Termination resistance should be equal to output impedance Z_{o} of the pulse generator.

Fig. 7. Test circuit for measuring switching times

Table 9. Test data

Supply voltage	Input		Load		Test
V _{CC}	V _I	t _r , t _f	CL	R _L	
1.2 V	V _{CC}	≤ 2.5 ns	50 pF	1 kΩ	t _{PHL} , t _{PLH}
2.0 V	V _{CC}	≤ 2.5 ns	50 pF	1 kΩ	t _{PHL} , t _{PLH}
2.7 V	2.7 V	≤ 2.5 ns	50 pF	1 kΩ	t _{PHL} , t _{PLH}
3.0 V to 3.6 V	2.7 V	≤ 2.5 ns	50 pF, 15 pF	1 kΩ	t _{PHL} , t _{PLH}
4.5 V to 5.5 V	V _{CC}	≤ 2.5 ns	50 pF	1 kΩ	t _{PHL} , t _{PLH}

8-bit serial-in/parallel-out shift register

11. Package outline

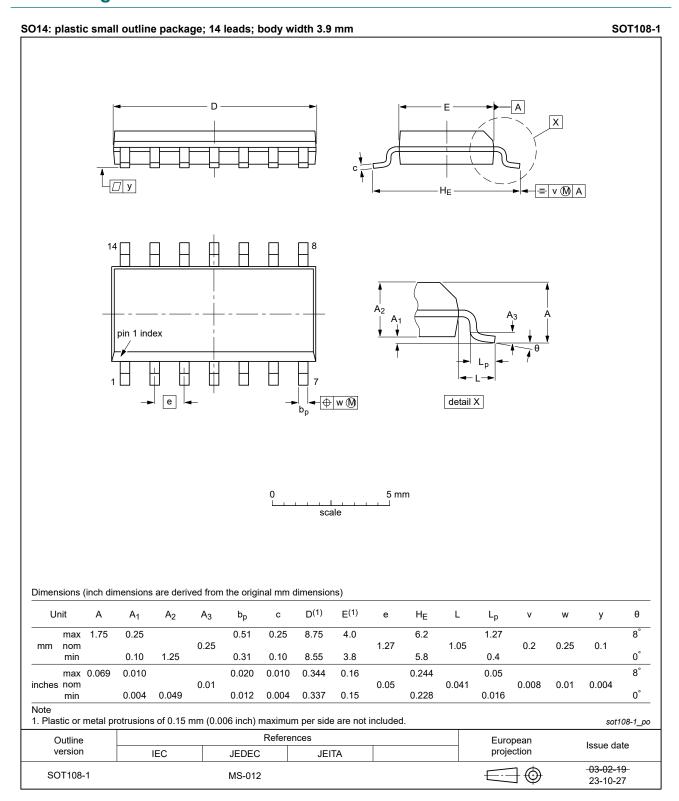


Fig. 8. Package outline SOT108-1 (SO14)

8-bit serial-in/parallel-out shift register

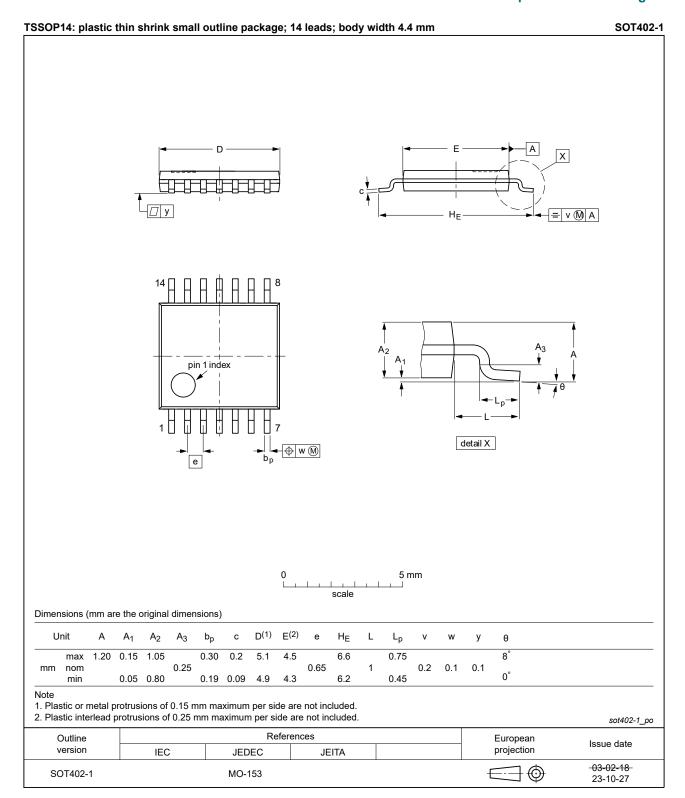


Fig. 9. Package outline SOT402-1 (TSSOP14)

8-bit serial-in/parallel-out shift register

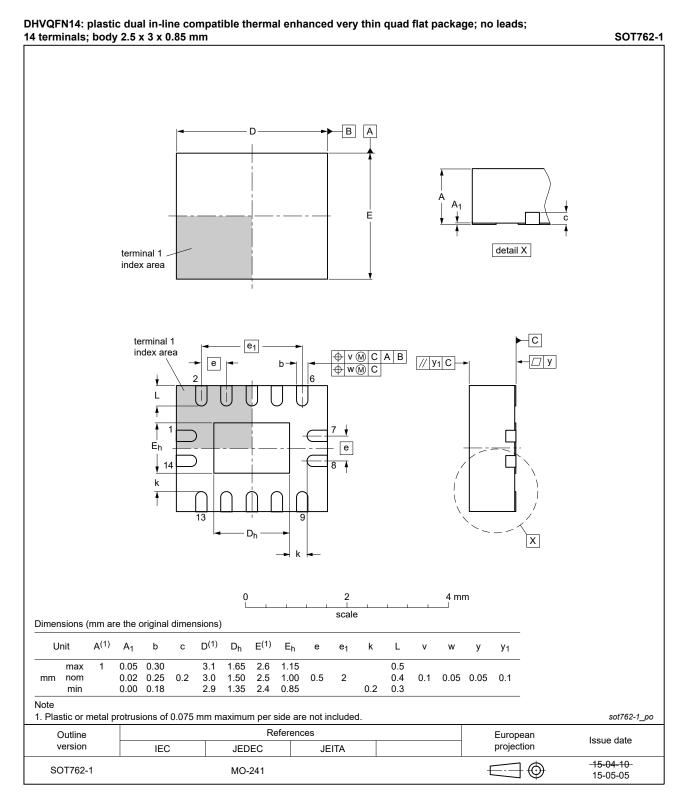


Fig. 10. Package outline SOT762-1 (DHVQFN14)

8-bit serial-in/parallel-out shift register

12. Abbreviations

Table 10. Abbreviations

Acronym	Description			
CDM	Charged Device Model			
CMOS	nplementary Metal Oxide Semiconductor			
DUT	Device Under Test			
ESD	ElectroStatic Discharge			
HBM	Human Body Model			
TTL	Transistor-Transistor Logic			

13. Revision history

Table 11. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes				
74LV164_Q100 v.4	20240131	Product data sheet	-	74LV164_Q100 v.3				
Modifications:		Section 2: ESD specification updated according to the latest JEDEC standard. Fig. 8, Fig. 9: Aligned SO and TSSOP package outline drawings to JEDEC MS-012 and MO-153						
74LV164_Q100 v.3	20200915	Product data sheet	-	74LV164_Q100 v.2				
Modifications:	guidelines o Legal texts I Section 2 up Table 4: Der	have been adapted to the r	new company nan	ne where appropriate.				
74LV164_Q100 v.2	20140918	Product data sheet	-	74LV164_Q100 v.1				
Modifications:	Section 2: ESD protection: MIL-STD-833 changed to MIL-STD883							
74LV164_Q100 v.1	20130626	Product data sheet	-	-				

Product data sheet

8-bit serial-in/parallel-out shift register

14. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

- Please consult the most recently issued document before initiating or completing a design.
- [2] The term 'short data sheet' is explained in section "Definitions".
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Product data sheet

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Nexperia

8-bit serial-in/parallel-out shift register

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